

Notice of References Cited	Application/Control No. 10/572,083	Applicant(s)/Patent Under Reexamination WEI ET AL.	
	Examiner Heather Anderson	Art Unit 1655	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-			
	B	US-			
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	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	CN-1375316-A	10-2002	China	Guo et al.(Derwent Abstr)	
	O					
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NON-PATENT DOCUMENTS

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